

Dr Stephen John Sweeney

Refereed Journal Papers

- J1. "Influence of carrier leakage on temperature performance of InAs/AlSb quantum cascade lasers", I. P. Marko, A. R. Adams, **S. J. Sweeney**, R. Teissier and A. N. Baranov, *accepted for publication in Physica Status Solidi (b)*, 4 pages (2008).
- J2. "Novel room temperature characterisation of InGaAlAs quantum well laser structures using electro-modulated reflectance and surface photovoltage spectroscopy", N. E. Fox, T. K. Sharma, **S. J. Sweeney** and T. J. C. Hosea, *accepted for publication in Physica Status Solidi (a)*, 8 pages (2008).
- J3. "Band anti-crossing and carrier recombination in dilute nitride phosphide based lasers and light emitting diodes", J. Chamings, S. Ahmed, A. R. Adams, **S. J. Sweeney**, V. A. Obnobyudov, C. W. Tu, B. Kunert, K. Volz and W. Stolz, *Physica Status Solidi (b)* *accepted for publication in Physica Status Solidi (b)*, 4 pages (2008).
- J4. "An accurate determination of the electronic transitions in InAs/InGaAs/InP quantum dots for mid-IR lasers using simultaneous complementary spectroscopic techniques", T. K. Sharma, T. J. C. Hosea, **S. J. Sweeney** and X. Tang, *accepted for publication in Jour. Appl. Phys.*, 7 pages (2008).
- J5. "Temperature dependence and physical properties of Ga(NAsP) semiconductor lasers", J. A. Chamings, A. R. Adams, **S. J. Sweeney**, B. Kunert, K. Volz and W. Stolz, *Appl. Phys. Lett.*, **93** pp101108-101110 (2008).
- J6. "Physical properties and Efficiency of GaNP Light Emitting Diodes", J. Chamings, S. Ahmed, **S. J. Sweeney**, V. A. Obnobyudov and C. W. Tu, *Appl. Phys. Lett.* **92**, pp021101-021103 (2008).
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- J8. "Optimisation of Distributed Feedback Lasers for Biosensing applications", J. Coote, S. R. Reddy and **S. J. Sweeney**, *IET Optoelectronics*, **1**, pp266-271 (2007).
- J9. "Temperature and pressure dependence of the recombination processes in 1.5 μ m InAs/InP (311)B quantum dot lasers", N. F. Massé, E. Homeyer, A. R. Adams, **S. J. Sweeney**, O. Dehaese, R. Piron, F. Grillot, S. Loualiche, *Appl. Phys. Lett.* **91**, pp131113-131115 (2007).
- J10. "Microscopic electroabsorption lineshape analysis for GaAsSb/GaAs heterostructures", C. Bückers, G. Blume, A. Thränhardt, C. Schlichenmaier, P. J. Klar, G. Weiser, S. W. Koch, J. Hader, J. V. Moloney, T. J. C. Hosea, **S. J. Sweeney**, S. R. Johnson and Y.-H. Zhang, *Jour. Appl. Phys.*, **101**, pp033118-033125 (2007).
- J11. "Experimental determination of the band gap dependence of Auger recombination in InGaAs/InP multiple-quantum well lasers at room temperature", N. F. Masse, A. R. Adams and **S. J. Sweeney**, *Appl. Phys. Lett.*, **90**, pp161113-161115 (2007).
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- J13. "High pressure studies of mid-infrared type-II "W" diode lasers at cryogenic temperatures", K. O'Brien, A. R. Adams, **S. J. Sweeney**, S. R. Jin, C. N. Ahmad, B. N. Murdin, C. L. Canedy, I. Vurgaftman and J. R. Meyer, *Physica Status Solidi (b)*, **244**, pp224-228 (2007).
- J14. "Band gap dependence of the recombination processes in InAs/GaAs quantum dots studied using hydrostatic pressure", I. P. Marko, A. R. Adams, **S. J. Sweeney**, N. F. Masse, R. Krebs, J. P. Reithmaier, A. Forchel, D. J. Mowbray, M. S. Skolnick, H. Y. Liu, K. M. Groom, N. Hatori and M. Sugawara, *Physica Status Solidi (b)*, **244**, pp82-86 (2007).
- J15. "Temperature and Pressure Dependence of Carrier Recombination Processes in GaAsSb/GaAs Quantum Well Lasers", K. Hild, **S. J. Sweeney**, I. P. Marko, S. R. Jin, S. R. Johnson, S. A. Chaparro, S. Yu and Y.-H. Zhang, *Physica Status Solidi (b)*, **244**, pp197-202 (2007).

- J16. "The temperature and pressure dependence of carrier recombination processes in 1.3 μ m and 1.5 μ m GaInNAs lasers", D. G. McConville, **S. J. Sweeney**, A. R. Adams, S. Tomic and H. Riechert, *Physica Status Solidi (b)*, **244**, pp208-212 (2007).
- J17. "Carrier recombination mechanisms in mid-infrared GaInAsSb quantum well lasers", K. O'Brien, **S. J. Sweeney**, A. R. Adams, S. R. Jin, C. N. Ahmad, B. N. Murdin, A. Salhi, Y. Rouillard and A. Joullie, *Physica Status Solidi (b)*, **244**, pp203-207 (2007).
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- J20. "Spectroscopy of GaAs/AlGaAs quantum-cascade lasers using hydrostatic pressure", S. R. Jin, C. N. Ahmad, **S. J. Sweeney**, A. R. Adams, B. N. Murdin, H. Page, X. Marcadet, C. Sitori and S. Tomic, *Applied Physics Letters*, **89**, p221105-221107 (2006).
- J21. "Recombination processes in mid-infrared InGaAsSb diode lasers emitting at 2.37 μ m", K. O'Brien, **S. J. Sweeney**, A. R. Adams, B. N. Murdin, A. Salhi, Y. Rouillard and A. Joullie, *Appl. Phys. Lett.*, **89**, pp051104-051106 (2006).
- J22. "Carrier transport and recombination in p-doped and intrinsic 1.3 μ m InAs/GaAs quantum-dot lasers", I. P. Marko, N. F. Masse, S. J. Sweeney, A. D. Andreev, A. R. Adams, N. Hatori and M. Sugawara, *Appl. Phys. Lett.*, **87**, pp211114-211116 (2005) [Also selected by the editor for publication in the Virtual Journal of Nanoscale Science and Technology, 28th November 2005 edition, see www.vjnano.org].
- J23. "Recombination and loss mechanisms in low-threshold InAs/GaAs 1.3 μ m quantum dot lasers", I. P. Marko, A. R. Adams, **S. J. Sweeney**, D. J. Mowbray, M. S. Skolnick, H. Y. Liu and K. M. Groom, *IEEE Jour. Sel. Top. Quant. Electr.*, **11**, pp.1041-1047 (2005).
- J24. "High temperature operation of 760nm vertical-cavity surface-emitting lasers investigated using photomodulated reflectance wafer measurements and temperature-dependent device studies", S. A. Cripps, T. J. C. Hosea, **S. J. Sweeney**, D. Lock, T. Leinonen, J. Lyytikäinen, and M. Dumitrescu, *IEE Proc. Optoelectronics*, **152**, pp103-109 (2005).
- J25. "Spectroscopic investigations of GaAsSb/GaAs based structures for 1.3 μ m VCSEL applications", G. Blume, T. J. C. Hosea, **S. J. Sweeney**, S. R. Johnson, J.-B. Wang, Y.-H. Zhang, *IEE Proc. Optoelectronics*, **152**, pp110-117 (2005).
- J26. "A study of the low-energy interference oscillations in photoreflectance of GaAsSb/GaAs quantum well structures", G. Blume, T. J. C. Hosea and **S. J. Sweeney**, *Physica Status Solidi (a)*, **202**, pp1244-1254 (2005).
- J27. "AlGaInN resonant-cavity LED devices studied by electro-modulated reflectance and carrier lifetime techniques", G. Blume, T. J. C. Hosea, **S. J. Sweeney**, P. de Mierry and D. Lancefield, *IEE Proc. Optoelectronics*, **152**, pp118-124 (2005).
- J28. "Novel Experimental Techniques for Semiconductor Laser Characterisation and Optimisation", **S. J. Sweeney**, *Physica Scripta*, **T114**, pp152-158, (2004).
- J29. "Temperature and pressure dependence of recombination processes in 1.5 μ m InGaAlAs/InP-based quantum well lasers" (invited), **S. J. Sweeney**, D. McConville, N. F. Massé, R.-X. Bouyssou, A. R. Adams, C. N. Ahmad and C. Hanke, *Physica Status Solidi (b)*, **241**, pp3391-3398 (2004).
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- J31. "Carrier recombination processes in 1.3 μ m and 1.5 μ m InGaAs(P)-based lasers at cryogenic temperatures and high pressures", **S. J. Sweeney**, S. R. Jin, C. N. Ahmad, A. R. Adams and B. N. Murdin, *Physica Status Solidi (b)*, **241**, pp3399-3404 (2004).
- J32. "Recombination mechanisms in InAs/InP quantum dash lasers studied using high hydrostatic pressure", I. P. Marko, **S. J. Sweeney**, A. R. Adams, S. R. Jin, B. N. Murdin, R. Schwertberger, A. Somers, J. P. Reithmaier and A. Forchel, *Physica Status Solidi (b)*, **241**, pp3427-3431 (2004).
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- J34. "Carrier leakage suppression utilising short-period super-lattices in 980nm InGaAs/GaAs quantum well lasers", D. Lock, **S. J. Sweeney**, A. R. Adams, S. Deubner, F. Klopff, J.P. Reithmaier and A. Forchel, *Physica Status Solidi (b)*, **241**, pp3405-3409 (2004).
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Book Chapters / Edited Works

- B1. "Selected Papers from the Second International Conference on Optical, Optoelectronic and Photonic Materials and Applications, 2007", Jour. Mat. Sci.: Materials in Electronics, edited by **S. J. Sweeney** and S. Krause, Springer, 2008.
- B2. "Optoelectronic Devices and Materials", **S. J. Sweeney** and A. R. Adams, in Springer Handbook of Electronic and Photonic Materials, Springer, ISBN 0387260595, August 2006.
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Refereed conference articles

- D1. "Band alignment and carrier recombination in GaAsSb/GaAs quantum wells", K. Hild, **S. J. Sweeney**, S. R. Jin, S. Healy, E. P. O'Reilly, S. R. Johnson, S. A. Chaparro, S. Yu and Y.-H. Zhang, AIP Conf. Series, **893**, pp1431-1432 (2007).
- D2. "Recombination, Transport and Loss Mechanisms in p-doped InAs/GaAs Quantum Dots", I. P. Marko, N. F. Masse, **S. J. Sweeney**, A. R. Adams, N. Hatori and M. Sugawara, AIP Conf. Series, **893**, pp837-838 (2007).
- D3. "Low threshold 2.37µm InGaAsSb/GaSb QW lasers: Towards the ideal Quantum Well laser?", K. O'Brien, **S. J. Sweeney**, A. R. Adams, B. N. Murdin, A. Sahli, Y. Rouillard and A. Joullie, Proc.12th International conference on Narrow Gap Semiconductors (2005).
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- D5. "Investigation of Carrier Recombination Processes and Transport Properties in GaInAsN/GaAs Quantum Wells", R. Fehse, **S. J. Sweeney**, A. R. Adams, D. McConville, E. P. O'Reilly, H. Riechert and L. Geelhaar Proc. ICPS, **772**, pp985-986 (2005).

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- D8. "Intrinsic temperature sensitivities of 1.3 μ m GaInNAs/GaAs, InGaAsP/InP and AlGaInAs/InP-based semiconductor lasers", **S. J. Sweeney**, R. Fehse, A. R. Adams and H. Riechert, Proc. 16th LEOS, **1**, pp39-40 (2003).
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- D10. "Fundamental limitations of high power 980nm InGaAs/GaAs pump lasers", D. Lock, **S. J. Sweeney** and A. R. Adams, Proc. 16th LEOS, **1**, pp427-428 (2003).
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- D12. "Novel electronic and optoelectronic properties of GaInNAs and related alloys", E. P. O'Reilly, S. Fahy, A. Lindsay, S. Tomic, R. Fehse, A. R. Adams, **S. J. Sweeney**, A. D. Andreev, P. J. Klar, H. Gruning and H. Riechert, CLEO 03 Technical Digest, pp520-522 (2003).
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- D15. "The temperature and pressure dependence of 1.3 μ m GaInNAs vertical-cavity surface-emitting lasers (VCSELs)", G. Knowles, R. Fehse, S. Tomic, **S. J. Sweeney**, T. E. Sale, A. R. Adams, E. P. O'Reilly, G. Steinle and H. Riechert, Proc. 18th ISLC, pp139-140 (2002).
- D16. "Optical investigation of recombination processes in GaInNAs, InGaAsP and AlGaInAs quantum-well lasers using hydrostatic pressure", S. R. Jin, **S. J. Sweeney**, G. Knowles, A. R. Adams, T. Higashi, H. Riechert and P. J. A. Thijs, Proc. 18th ISLC, pp83-84 (2002).
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- D18. "The temperature dependence of the recombination processes in 1.3 μ m GaInNAs-based edge emitting lasers", R. Fehse, S. R. Jin, **S. J. Sweeney**, A. R. Adams, E. P. O'Reilly, S. Illek, A. Yu. Egorov and H. Riechert, Proc. 14th LEOS, **1**, p12-13 (2001).
- D19. "The effect of Auger generated hot-holes on 1.5 μ m InGaAs(P)-based quantum well semiconductor lasers", **S. J. Sweeney**, A. R. Adams, E. P. O'Reilly, M. Silver and P. J. A. Thijs, CLEO 00 Technical Digest, pp391-392 (2000).
- D20. "-180 to +80°C CW lasing in visible VCSELs", T. E. Sale, G. C. Knowles, S. J. Sweeney, A. Onischenko, J. E. F. Frost, S. M. Pinches and J. Woodhead, Proc. 17th ISLC, pp15-17 (2000).
- D21. "Determination of the Influence of Auger Recombination on the Threshold Current of 1.3 μ m and 1.5 μ m InGaAs(P) Strained-layer Lasers and its Variation with Temperature", **S. J. Sweeney**, A. F. Phillips, A. R. Adams, E. P. O'Reilly and P. J. A. Thijs, Proc. 16th ISLC, pp63-64 (1998).
- D22. "Observation of reduced non-radiative recombination current in 1.3 μ m AlGaInAs/InP multiple-quantum-well lasers", T. Higashi, **S. J. Sweeney**, A. F. Phillips, A. R. Adams, E. P. O'Reilly, T. Uchida and T. Fujii, Proc. 16th ISLC, pp61-62 (1998).

- D23. “Transition from radiative to nonradiative recombination in 1.3 μ m and 1.5 μ m InGaAs(P) multiple quantum well semiconductor diode lasers”, **S. J. Sweeney**, A. F. Phillips, A. R. Adams, E. P. O’Reilly, M. Silver and P. J. A. Thijs, CLEO 98 Technical Digest, pp304 (1998).
- D24. “The Influence of Phonon-assisted Auger Recombination on the Electroluminescent Efficiency of InGaAsP Bulk, Strained and Unstrained Quantum-Well Structures”, A.R. Adams, E.P. O’Reilly, M. Silver, A.F. Phillips, **S.J. Sweeney** and P.J.A. Thijs, Proc. ICPS, **1**, pp293- 296 (1996).

Conference Presentations

NB: Oral presentations are indicated by *.
Invited presentations are indicated by †.

- C1. * † “The effect of hydrostatic pressure on the operation of quantum cascade lasers”, A. R. Adams, I. P. Marko, **S. J. Sweeney**, R. Teissier, A. Baranov and S. Tomic, *to be presented at* Photonics West, San Jose, USA, January 2009.
- C2. * † “Quantum efficiency measurements using semiconductor lasers”, **S. J. Sweeney**, *to be presented at* Photonics West, San Jose, USA, January 2009.
- C3. * “The physics of dilute nitride-phosphide based QW lasers”, **S. J. Sweeney**, J. Chamings, S. Ahmed, A. R. Adams, B. Kunert, K. Volz and W. Stolz, *to be presented at* Photonics West, San Jose, USA, January 2009.
- C4. * “The persistence of Auger recombination in InAs/GaAs quantum dot lasers”, **S. J. Sweeney**, A. R. Adams, I. P. Marko, N. F. Masse, A. D. Andreev, M. T. Crowley and E. P. O’Reilly, *to be presented at* Photonics West, San Jose, USA, January 2009.
- C5. * “The Development of a compact free spectral range semiconductor laser biosensor”, J. Coote, S. Reddy and **S. J. Sweeney**, European Optical Society: Topical meeting on Biophotonics, Paris, France, October 2008.
- C6. * “Thermal properties of silicon compatible GaNAsP SQW lasers”, J. Chamings, A. R. Adams, **S. J. Sweeney**, B. Kunert, K. Volz and W. Stolz, International Semiconductor Laser Conference (ISLC), Sorrento, Italy, September 2008.
- C7. “Thermal characteristics of 1.3 μ m GaAsSb/GaAs-based Edge- and Surface-emitting Lasers”, **S. J. Sweeney**, K. Hild, I. P. Marko, S.-Q. Yu, S. R. Johnson and Y. H. Zhang, International Semiconductor Laser Conference (ISLC), Sorrento, Italy, September 2008.
- C8. * “Gamma-L scattering in InAs-based QCLs studied using high hydrostatic pressure”, I. P. Marko, A. R. Adams, **S. J. Sweeney**, R. Teissier, A. N. Baranov and S. Tomic, International Semiconductor Laser Conference (ISLC), Sorrento, Italy, September 2008.
- C9. “The importance of recombination via excited states in InAs/GaAs 1.3 μ m quantum dot lasers”, M. Crowley, I. P. Marko, N. F. Masse, A. D. Andreev, **S. J. Sweeney**, E. P. O’Reilly and A. R. Adams, International Semiconductor Laser Conference (ISLC), Sorrento, Italy, September 2008.
- C10. * “Band anti-crossing and carrier recombination in dilute nitride phosphide based lasers and light emitting diodes”, J. Chamings, S. Ahmed, A. R. Adams, **S. J. Sweeney**, V. A. Obnolyudov, C. W. Tu, B. Kunert, K. Volz and W. Stolz, High Pressure Semiconductor Physics (HPSP-XIII), Brazil, July 2008.
- C11. * “Influence of carrier leakage on temperature performance of InAs/AlSb quantum cascade lasers”, I. P. Marko, A. R. Adams, **S. J. Sweeney**, R. Teissier and A. N. Baranov, High Pressure Semiconductor Physics (HPSP-XIII), Brazil, July 2008.
- C12. * “Temperature performance of short wavelength InAs/AlSb quantum cascade lasers studied using high hydrostatic pressure”, I. P. Marko, A. R. Adams, **S. J. Sweeney**, R. Teissier, A. N. Baranov and S. Tomic, UK Compound Semiconductors, Sheffield, July 2008.

- C13. * “Free spectral range biochemical sensor”, J. Coote, B. Murdin, S. Reddy and **S. J. Sweeney**, UK Compound Semiconductors, Sheffield, July 2008.
- C14. * “Dilute nitride phosphide based lasers and light emitting diodes”, J. Chamings, S. Ahmed, A. R. Adams, **S. J. Sweeney**, V. A. Obnolyudov, C. W. Tu, B. Kunert, K. Volz and W. Stolz, UK Compound Semiconductors, Sheffield, July 2008.
- C15. * “Room temperature characterisation of novel InGaAlAs quantum well lasers using electro-modulated reflectance and surface photovoltage spectroscopy”, N. Fox, T. K. Sharma, **S. J. Sweeney** and T. J. C. Hosea, 3rd International Workshop on Modulation Spectroscopy of Semiconductor Structures, Wroclaw, Poland, July 2008.
- C16. * “Novel heterostructure design for increased spectral width of superluminescent diodes and dual-wavelength laser diodes”, B. C. Green, S.-Q. Yu, **S. J. Sweeney**, D. Ding and Y. H. Zhang, Device Research Conference, Santa Barbara, USA, June, 2008.
- C17. * ¶ “Materials and Light-Emitting Diode Properties of Dilute-Nitride GaNP/GaP Heterostructures”, C. W. Tu, V. A. Obnolyudov, J. Chamings, S. Ahmed, **S. J. Sweeney** and D. M. Keogh, Device Research Conference, Santa Barbara, USA, June, 2008.
- C18. * ¶ “Efficiency Limiting processes in semiconductor lasers: challenges and solutions”, **S. J. Sweeney**, 3rd International Conference on Smart Materials, Structures and Systems (CIMTEC 2008), Sicily, June 2008.
- C19. * ¶ “Efficiency limiting processes in infrared semiconductor lasers”, **S. J. Sweeney**, Solid State Diode Laser Technology Review (SSDLTR) meeting, Albuquerque, USA, June 2008.
- C20. * “Reliable 1550nm SI BH lasers fabricated using an improved Ru precursor”, I. Lealman, S. Dosanjh, L. Rivers, P. Cannard, **S. J. Sweeney**, I. P. Marko and S. Rushworth, Indium Phosphide and related Materials (IPRM08), Versailles, France, May 2008.
- C21. * “Investigation of the dark current in bulk GaInNAs Photodiodes”, W. M. Soong, J. S. Ng, M. J. Steer, M. Hopkinson, J. P. R. David, J. Chamings, **S. J. Sweeney**, A. R. Adams and J. Allam, Semiconductor and Integrated Optoelectronics (SIOE 2008), Cardiff, UK, April 2008.
- C22. * ¶ “Mid-IR Lasers: What can we learn from the near-IR?”, **S. J. Sweeney**, Advanced Semiconductor Materials Conference, Tucson, USA, February 2008.
- C23. * “Radiative and Non-radiative Recombination via Excited States in InAs/GaAs 1.3 μ m Quantum Dot Lasers”, A. R. Adams, A. D. Andreev, I. P. Marko, N. F. Masse, **S. J. Sweeney**, M. Crowley and E. P. O’Reilly, IoP Quantum Dot One Day Meeting, London, UK, February 2008.
- C24. * ¶ “Physics challenges for near and mid-infrared semiconductor diode lasers”, **S. J. Sweeney**, Photonics West, San Jose, USA, January 2008.
- C25. * “Efficiency limiting processes in long wavelength (1.5 μ m) GaInAsN/GaAs lasers”, **S. J. Sweeney**, D. G. McConville, A. R. Adams, S. Tomic and H. Riechert Photonics West, San Jose, USA, January 2008.
- C26. * ¶ “Material Properties and Light-emitting Applications of Dilute Nitride GaNP Grown on GaP”, C. W. Tu, V. A. Obnolyudov, J. Chamings, S. Ahmed and **S. J. Sweeney**, International Conference on Advanced Materials and Devices, Jeju, Korea, December 2007.
- C27. * “Thermal Properties of 1.5 μ m InAs/InP Quantum Dot Lasers”, N. F. Masse, E. Homeyer, O. Dehaese, R. Piron, F. Grillot, S. Loualiche, A. R. Adams and **S. J. Sweeney**, European Semiconductor Laser Workshop (ESLW) 2007, Berlin, Germany, September 2007.
- C28. * “Semiconductor lasers as integrated optical biosensors: sensitivity optimisation”, J. Coote and **S. J. Sweeney**, Institute of Physics conference on Sensors and their Applications, Liverpool, UK, September 2007.
- C29. “Novel Phosphor-free white light emitting diodes for optimised eye response”, S. Ahmed, D. Lancefield, **S. J. Sweeney**, P. de Mierry, F. Tinjod and S. Chenot, International Conference on Nitride Semiconductors, Las Vegas, USA, September 2007.

- C30. * “Temperature Insensitive Quantum Dot Lasers – Are we really there yet?”, N. F. Masse, I. P. Marko, A. R. Adams and **S. J. Sweeney**, 2nd International Conference on Optical and Optoelectronic Properties of Materials and their Applications (ICOOPMA), London, UK, July 2007.
- C31. * “Dilute Nitride Phosphide Photonic Devices”, J. Chamings, S. Ahmed, **S. J. Sweeney**, V. A. Odnoblyudov, C. W. Tu, K. Volz and W. Stolz, 2nd International Conference on Optical and Optoelectronic Properties of Materials and their Applications (ICOOPMA), London, UK, July 2007.
- C32. “Can Semiconductor Lasers make good Sensors?”, J. Coote, S. Reddy and **S. J. Sweeney**, 2nd International Conference on Optical and Optoelectronic Properties of Materials and their Applications (ICOOPMA), London, UK, July 2007.
- C33. “Laser Sources for High Temperature Optoelectronics”, I. P. Marko, A. R. Adams, **S. J. Sweeney**, N. D. Whitbread, A. J. Ward, B. Asplin and D. J. Robbins, 2nd International Conference on Optical and Optoelectronic Properties of Materials and their Applications (ICOOPMA), London, UK, July 2007.
- C34. “Phosphor-free White Light-Emitting Diodes”, S. Ahmed, D. Lancefield, **S. J. Sweeney**, P. de Mierry, F. Tinjod and S. Chenot, 2nd International Conference on Optical and Optoelectronic Properties of Materials and their Applications (ICOOPMA), London, UK, July 2007 [*won best poster prize*].
- C35. “Long Wavelength Dilute Nitride-based Lasers and Detectors”, J. Chamings, D. McConville, **S. J. Sweeney**, A. R. Adams, J. S. Ng, W. M. Soong, M. Hopkinson, J. P. R. David, S. Tomic and H. Riechert, 2nd International Conference on Optical and Optoelectronic Properties of Materials and their Applications (ICOOPMA), London, UK, July 2007.
- C36. * “Carrier recombination and temperature sensitivity of 1.3-1.5 μ m GaInAsN/GaAs lasers”, **S. J. Sweeney**, D. G. McConville, A. R. Adams, S. Tomic and H. Riechert, UK Compound Semiconductors 2007, Sheffield, UK, July 2007.
- C37. * “The influence of carrier density non-pinning on the output power of 1.55 μ m lasers at high temperature”, I. P. Marko, A. R. Adams, **S. J. Sweeney**, N. D. Whitbread, A. J. Ward, B. Asplin and D. J. Robbins, CLEO-Europe, Munich, Germany, June 2007.
- C38. * “Temperature and Pressure Investigations of GaNAsP SQW lasers grown by MOVPE for Silicon based Optoelectronic Integrated Circuits”, J. A. Chamings, **S. J. Sweeney**, A. R. Adams, W. Stolz and B. Kunert, EMRS Spring meeting, Strasbourg, France, June 2007.
- C39. * “Wavelength and temperature dependence of carrier recombination processes in GaInAsN/GaAs lasers”, **S. J. Sweeney**, D. G. McConville, A. R. Adams, S. Tomic and H. Riechert, EMRS Spring meeting, Strasbourg, France, June 2007.
- C40. * “The dependence of Breakdown Voltage with Nitrogen content and Pressure of lattice-matched bulk GaInNAs for low-noise, high gain Avalanche Photodiodes”, J. A. Chamings, **S. J. Sweeney**, J. Allam, A. R. Adams, W. M. Soong, J. S. Ng, M. J. Steer, M. Hopkinson and J. P. R. David, EMRS Spring meeting, Strasbourg, France, June 2007.
- C41. “Temperature and Pressure dependent properties of GaNP Light Emitting Diodes”, S. Ahmed, J. Chamings, **S. J. Sweeney**, V. A. Odnoblyudov and C. W. Tu, EMRS Spring meeting, Strasbourg, France, June 2007 [*won best poster prize*].
- C42. * “High pressure studies of type-I GaInAsSb lasers”, K. O’Brien, **S. J. Sweeney**, A. R. Adams, S. R. Jin, C. N. Ahmad, B. N. Murdin, A. Salhi, Y. Rouillard, A. Joullie, Y. Cao, S. R. Johnson and Y.-H. Zhang, 8th International Conference on Mid-Infrared Optoelectronics: Materials and Devices (MIOMD), Bad Ischl, Austria, May 2007.
- C43. * “Influence of de-tuning and non-radiative recombination on the temperature dependence of 1.3 μ m GaAsSb/GaAs VCSELs”, K. Hild, I. P. Marko, **S. J. Sweeney**, S. R. Johnson, S. A. Chaparro, S. -Q. Yu and Y. -H. Zhang, Semiconductor and Integrated Optoelectronics conference (SIOE), Cardiff, UK, April, 2007.
- C44. “Optimisation of DFB Laser Biosensors”, J. Coote, S. Reddy and **S. J. Sweeney**, Semiconductor and Integrated Optoelectronics conference (SIOE), Cardiff, UK, April, 2007.

- C45. * “Recombination processes in 1.5 μ m InAs/InP Quantum Dot Lasers”, N. Masse, E. Homeyer, O. Dehaese, R. Piron, F. Grillot, S. Loualiche, A. R. Adams and **S. J. Sweeney**, Semiconductor and Integrated Optoelectronics conference (SIOE), Cardiff, UK, April, 2007.
- C46. * “GaPn/GaP Light Emitting Diodes: Material and Device Properties”, S. Ahmed, J. Chamings, **S. J. Sweeney**, V. A. Odnoblyudov and C. W. Tu, Institute of Physics GaInNAs One Day Meeting : Materials, Devices and Technology, Cardiff, UK, April 2007.
- C47. * “Impact Ionisation in GaInNAs-based Photodiodes”, J. A. Chamings, **S. J. Sweeney**, J. Allam, A. R. Adams, W. M. Soong, J. S. Ng, M. J. Steer, M. Hopkinson and J. P. R. David, Institute of Physics GaInNAs One Day Meeting : Materials, Devices and Technology, Cardiff, UK, April 2007.
- C48. * “Temperature and Pressure Investigations of GaNAsP/GaP SQW lasers for silicon based Optoelectronic Integrated Circuits”, J. A. Chamings, A. R. Adams, **S. J. Sweeney**, W. Stolz, K. Volz and B. Kunert, Institute of Physics GaInNAs One Day Meeting : Materials, Devices and Technology, Cardiff, UK, April 2007.
- C49. * ¶ “Recombination Processes in Dilute Nitride based Devices”, **S. J. Sweeney**, 3rd Metastable Systems and Heterostructures Dilute Nitride Materials Workshop, Marburg, Germany, December 2006.
- C50. * “Intrinsic limitations of p-doped and undoped 1.3 μ m InAs/GaAs quantum dot lasers”, N. F. Masse, **S. J. Sweeney**, I. P. Marko, A. D. Andreev and A. R. Adams, 20th IEEE International Semiconductor Laser Conference (ISLC), Hawaii, USA, September 2006.
- C51. “Temperature variation of the threshold current and gain in p-doped and intrinsic 1.3 μ m InAs/GaAs quantum dot lasers”, N. F. Masse, I. P. Marko, **S. J. Sweeney**, A. D. Andreev and A. R. Adams, European Semiconductor Laser Workshop, Nice, France, September 2006.
- C52. “Analysis of the major loss processes in mid-infrared type-II “W” diode lasers”, K. O’Brien, A. R. Adams, **S. J. Sweeney**, S. R. Jin, C. N. Ahmad, B. N. Murdin, C. L. Canedy, I. Vurgaftman and J. R. Meyer, 20th IEEE International Semiconductor Laser Conference (ISLC), Hawaii, USA, September 2006.
- C53. * “The temperature dependence of the peak gain in p-doped and intrinsic 1.3 μ m InAs/GaAs quantum-dot lasers”, N. F. Masse, I. P. Marko, **S. J. Sweeney**, A. D. Andreev, A. R. Adams, N. Hatori and M. Sugawara, Photon 06, Manchester, September 2006.
- C54. * “Material challenges for the development of long wavelength GaInNAs/GaAs quantum well lasers”, D. G. McConville, **S. J. Sweeney**, A. R. Adams and H. Riechert, Photon 06, Manchester, September 2006.
- C55. “Bulk p-i-n GaInNAs photodiodes lattice-matched to GaAs”, W. M. Soong, J. S. Ng, M. J. Steer, M. Hopkinson, J. P. R. David, J. Chamings, **S. J. Sweeney** and A. R. Adams, Photon 06, Manchester, September 2006.
- C56. * ¶ “Some Trends in the Fundamental Processes Occurring in Semiconductor Optoelectronic Devices”, A. R. Adams, **S. J. Sweeney** and J. Allam, 12th International Conference on High Pressure Semiconductor Physics (HPSP-XII), Barcelona, Spain, August 2006.
- C57. “Temperature and Pressure Dependence of Carrier Recombination Processes in GaAsSb/GaAs Quantum Well Lasers”, K. Hild, **S. J. Sweeney**, I. P. Marko, S. R. Jin, S. R. Johnson, S. A. Chaparro, S. Yu and Y.-H. Zhang, 12th International Conference on High Pressure Semiconductor Physics (HPSP-XII), Barcelona, Spain, August 2006.
- C58. “Experimental study of the pressure dependence of Auger recombination in InGaAs/InP 1.5 μ m quantum well lasers at room temperature”, N. F. Masse, **S. J. Sweeney** and A. R. Adams, 12th International Conference on High Pressure Semiconductor Physics (HPSP-XII), Barcelona, Spain, August 2006.
- C59. “Carrier recombination mechanisms in mid-infrared GaInAsSb quantum well lasers”, K. O’Brien, **S. J. Sweeney**, A. R. Adams, S. R. Jin, C. N. Ahmad, B. N. Murdin, A. Salhi, Y. Rouillard and A. Joullie, 12th International Conference on High Pressure Semiconductor Physics (HPSP-XII), Barcelona, Spain, August 2006.
- C60. “High pressure studies of mid-infrared type-II “W” diode lasers at cryogenic temperatures”, K. O’Brien, **S. J. Sweeney**, A. R. Adams, S. R. Jin, C. N. Ahmad, B. N. Murdin, C. L. Canedy, I. Vurgaftman and J. R. Meyer, 12th International Conference on High Pressure Semiconductor Physics (HPSP-XII), Barcelona, Spain, August 2006.

- C61. * “Band gap dependence of the recombination processes in InAs/GaAs quantum dots studied using hydrostatic pressure”, I. P. Marko, A. R. Adams, **S. J. Sweeney**, N. F. Masse, R. Krebs, J. P. Reithmaier, A. Forchel, D. J. Mowbray, M. S. Skolnick, H. Y. Liu, K. M. Groom, N. Hatori and M. Sugawara, 12th International Conference on High Pressure Semiconductor Physics (HPSP-XII), Barcelona, Spain, August 2006.
- C62. “The temperature and pressure dependence of carrier recombination processes in 1.3 μ m and 1.5 μ m GaInNAs lasers”, D. G. McConville, **S. J. Sweeney**, A. R. Adams, S. Tomic and H. Riechert, 12th International Conference on High Pressure Semiconductor Physics (HPSP-XII), Barcelona, Spain, August 2006.
- C63. “Band alignment and carrier recombination in GaAsSb/GaAs quantum wells”, K. Hild, **S. J. Sweeney**, S. R. Jin, S. Healy, E. P. O’Reilly, S. R. Johnson, S. A. Chaparro, S. Yu and Y.-H. Zhang, 28th International Conference on the Physics of Semiconductors (ICPS 2006), Vienna, Austria, July 2006.
- C64. “Recombination, Transport and Loss Mechanisms in p-doped InAs/GaAs Quantum Dots”, I. P. Marko, N. F. Masse, **S. J. Sweeney**, A. R. Adams, N. Hatori and M. Sugawara, 28th International Conference on the Physics of Semiconductors (ICPS 2006), Vienna, Austria, July 2006.
- C65. * ¶ “Thermally Stable 1.3-1.6 μ m Semiconductor Lasers: Physics and Materials Challenges”, **S. J. Sweeney** and A. R. Adams, International Conference on Optical and Optoelectronic Properties of Materials and Applications (ICOOPMA 2006), Darwin, Australia, July 2006.
- C66. * “Wavelength dependence of recombination mechanisms in 1.3 μ m-1.5 μ m GaInNAs quantum well laser devices”, D. G. McConville, **S. J. Sweeney**, A. R. Adams, H. Riechert and S. Tomic, Rank Prize Fund Mini-Symposium on Dilute Nitrides, Windermere, UK, June 2006.
- C67. * “The band gap dependence of impact ionization in GaInNAs”, J. Chamings, A. R. Adams, **S. J. Sweeney**, J. P. R. David, J. S. Ng and W. M. Soon, Rank Prize Fund Mini-Symposium on Dilute Nitrides, Windermere, UK, June 2006.
- C68. * ¶ “Photonic-based Biosensors”, **S. J. Sweeney**, DTI Gas Sensing and Analysis group meeting, Chelmsford, UK, April 2006.
- C69. * “Influence of carrier transport on the gain in p-doped and intrinsic 1.3 μ m InAs/GaAs quantum dot lasers”, N. F. Masse, I. P. Marko, **S. J. Sweeney**, A. R. Adams, N. Hatori and M. Sugawara, Semiconductor and Integrated Optoelectronics conference (SIOE 2006), Cardiff, UK, April 2006.
- C70. * “The wavelength dependence of recombination mechanisms in MBE grown GaInNAs/GaAs quantum well lasers”, D. G. McConville, **S. J. Sweeney**, A. R. Adams, R. Averbeck and H. Riechert, Semiconductor and Integrated Optoelectronics conference (SIOE 2006), Cardiff, UK, April 2006 [Also presented at the IoP workshop on Dilute Nitrides, Cardiff, April 2006].
- C71. “The effect of Catastrophic Optical Damage on 980nm semiconductor lasers investigated using pressure and facet temperature techniques”, D. Lock, **S. J. Sweeney** and A. R. Adams, Semiconductor and Integrated Optoelectronics conference (SIOE 2006), Cardiff, UK, April 2006.
- C72. * “Dark current characteristics in thick bulk GaInNAs lattice-matched to GaAs”, W. M. Soong, J. G. Ng, M. J. Steer, M. Hopkinson, J. P. R. David, J. Chamings, **S. J. Sweeney** and A. R. Adams, Semiconductor and Integrated Optoelectronics conference (SIOE 2006), Cardiff, UK, April 2006.
- C73. “Effect of non thermal carrier distribution on the properties of 1.3 μ m InAs/GaAs quantum dot lasers”, N. F. Masse, I. P. Marko, **S. J. Sweeney**, A. D. Andreev, A. R. Adams, N. Hatori and M. Suguwara, Condensed Matter and Materials Physics conference (CMMP 2006), Exeter, UK, April 2006.
- C74. * “Temperature and Band gap Dependence of Carrier Recombination Processes in GaAsSb/GaAs Quantum Well Lasers”, K. Hild, I. P. Marko, S. R. Jin, **S. J. Sweeney**, J.-B. Wang, S. R. Johnson and Y.-H. Zhang, European Physical Society Meeting (DPG/EPS 2006), Dresden, Germany, March 2006.
- C75. * “Spectroscopic investigations of GaAsSb/GaAs structures for 1.3 μ m VCSEL applications”, G. Blume, T. J. C. Hosea, **S. J. Sweeney**, P. J. Klar, G. Weiser, C. Bueckers, A. Thraenhardt, S. W. Koch, S. R. Johnson and Y. H. Zhang, European Physical Society Meeting (DPG/EPS 2006), Dresden, Germany, March 2006.

- C76. * [¶] “The Physics Controlling the Sensitivity of Semiconductor Lasers to High Temperatures”, A. R. Adams and **S. J. Sweeney**, OFC/NFOEC, Anaheim, USA, March 2006.
- C77. * “Temperature insensitive operation of p-doped Quantum Dot lasers emitting at 1.3 μm ”, N. F. Masse, I. P. Marko, **S. J. Sweeney**, A. R. Adams, N. Hatori and M. Sugawara, Qinetiq one day quantum dot meeting, Malvern, UK, January 2006.
- C78. * “The influence of p-doping on the temperature sensitivity of 1.3 μm Quantum Dot Lasers”, N. F. Masse, I. P. Marko, **S. J. Sweeney**, A. R. Adams, N. Hatori and M. Sugawara, Lasers and Electro-Optics Annual Meeting (LEOS 2005), Sydney, Australia, October 2005.
- C79. * “On the thermal stability of 1.3 μm GaAsSb/GaAs-based lasers”, K. Hild, **S. J. Sweeney**, D. A. Lock, S. Wright, J.-B. Wang, S. R. Johnson and Y.-H. Zhang, Lasers and Electro-Optics Annual Meeting (LEOS 2005), Sydney, Australia, October 2005.
- C80. * “Effect of gain saturation and nonradiative recombination on the thermal characteristics of InAs/GaAs 1.3 μm quantum dot lasers”, I. P. Marko, N. Masse, **S. J. Sweeney**, A. R. Adams, I. R. Sellers, D. J. Mowbray, M. S. Skolnick, H. Y. Liu and K. M. Groom, Lasers and Electro-Optics Annual Meeting (LEOS 2005), Sydney, Australia, October 2005.
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